

TOSHIBA Photocoupler GaAlAs Ired & Photo-IC

TLP114A

Digital Logic Isolation.

Line Receiver.

Power Supply Control Feedback Control.

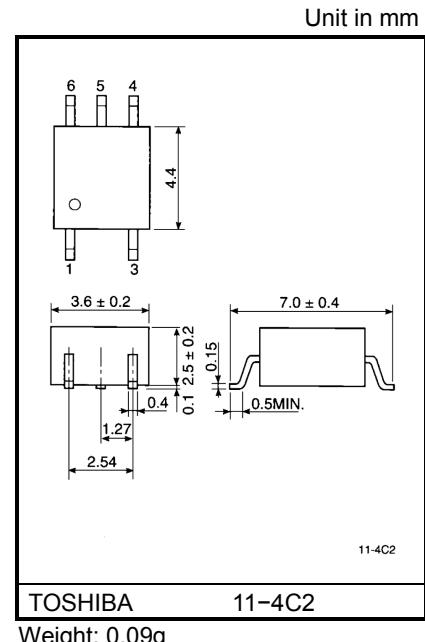
Switching Power Supply.

Transistor Invertor.

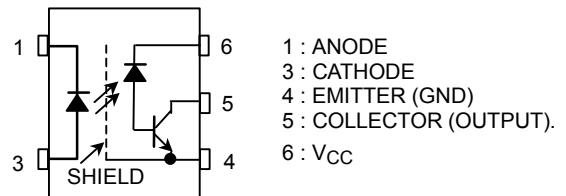
The TOSHIBA mini flat coupler TLP114A is a small outline coupler, suitable for surface mount assembly.

TLP114A consists of a high output power GaAlAs light emitting diode, optically coupled to a high speed detector of one chip photodiode-transistor.

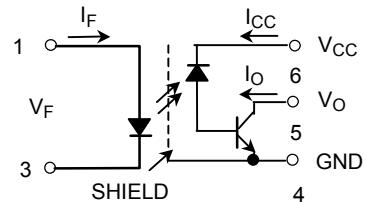
- Isolation voltage: 3750 Vrms (min.)
- Switching speed: $t_{pHL} = 0.8\mu s$, $t_{pLH} = 0.8\mu s$ (max.) ($R_L = 1.9 k\Omega$)
- TTL compatible
- UL recognized: UL1577, file no. E67349



Pin Configuration (top view)



Schematic



Maximum Ratings ($T_a = 25^\circ C$)

	Characteristic	Symbol	Rating	Unit
LDE	Forward current (Note 1)	I_F	20	mA
	Pulse forward current (Note 2)	I_{FP}	40	mA
	Peak transient forward current (Note 3)	I_{FPT}	1	A
	Reverse voltage	V_R	5	V
Detector	Output current	I_O	8	mA
	Peak output current	I_{OP}	16	mA
	Supply voltage	V_{CC}	-0.5~30	V
	Output voltage	V_o	-0.5~20	V
	Output power dissipation (Note 4)	P_o	100	mW
Operating temperature range		T_{opr}	-55~100	°C
Storage temperature range		T_{stg}	-55~125	°C
Lead solder temperature(10 sec.)		T_{sol}	260	°C
Isolation Voltage (AC,1 min., R.H.≤ 60%)		BV_S	3750	Vrms

(Note 1) Derate 0.36mA / °C above 70°C.

(Note 2) 50% duty cycle, 1ms pulse width.

Derate 0.72mA / °C above 70°C.

(Note 3) Pulse width≤ 1μs, 300pps.

(Note 4) Derate 1.8mW / °C above 70°C.

Electrical Characteristics (Ta = 25°C)

	Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
LDE	Forward voltage	V _F	I _F = 16mA	1.22	1.42	1.72	V
	Forward voltage temperature coefficient	ΔV _F / ΔT _a	I _F = 16mA	—	—2	—	mV /°C
	Reverse current	I _R	V _R = 3V	—	—	10	μA
	Capacitance between terminals	C _T	V _F = 0, f = 1MHz	—	30	—	pF
Detector	High level output current	I _{OH} (1)	I _F = 0mA, V _{CC} = V _O = 5.5V	—	3	500	nA
		I _{OH} (2)	I _F = 0mA, V _{CC} = 30V V _O = 20V	—	—	5	μA
		I _{OH}	I _F = 0mA, V _{CC} = 30V V _O = 20V, T _a = 70°C	—	—	50	
	High level supply current	I _{CCH}	I _F = 0mA, V _{CC} = 30V	—	0.01	1	μA
Coupled	Current transfer ratio	I _O / I _F	I _F = 16mA, V _{CC} = 4.5V V _O = 0.4V	20	—	—	%
	Low level output voltage	V _{OL}	I _F = 16mA, V _{CC} = 4.5V I _O = 2.4 mA	—	—	0.4	V
	Isolation resistance	R _S	R.H.≤ 60%, V _S = 500V (Note 5)	5×10 ¹⁰	10 ¹⁴	—	Ω
	Stray capacitance between input to output	C _S	V _S = 0, f = 1MHz (Note 5)	—	0.8	—	pF

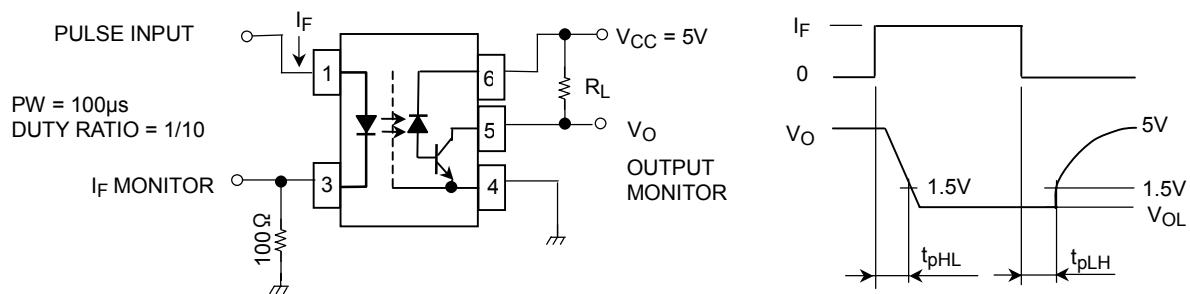
Switching Characteristics (Ta = 25°C, VCC = 5V)

Characteristic	Symbol	Test Circuit	Test Condition	Min.	Typ.	Max.	Unit
Propagation delay time (H→ L)	t _{pHL}	1	I _F = 0→ 16mA V _{CC} = 5V, R _L = 1.9kΩ	—	—	0.8	μs
Propagation delay time (L→ H)	t _{pLH}	1	I _F = 16→ 0mA V _{CC} = 5V, R _L = 1.9kΩ	—	—	0.8	μs
Common mode transient immunity at high output level	C _{MH}	2	I _F = 0mA, V _{CM} = 400V _{p-p} R _L = 4.1kΩ	5000	10000	—	V / μs
Common mode transient immunity at low output level	C _{ML}	2	I _F = 16mA, V _{CM} = 400V _{p-p} R _L = 4.1kΩ	-5000	-10000	—	V / μs

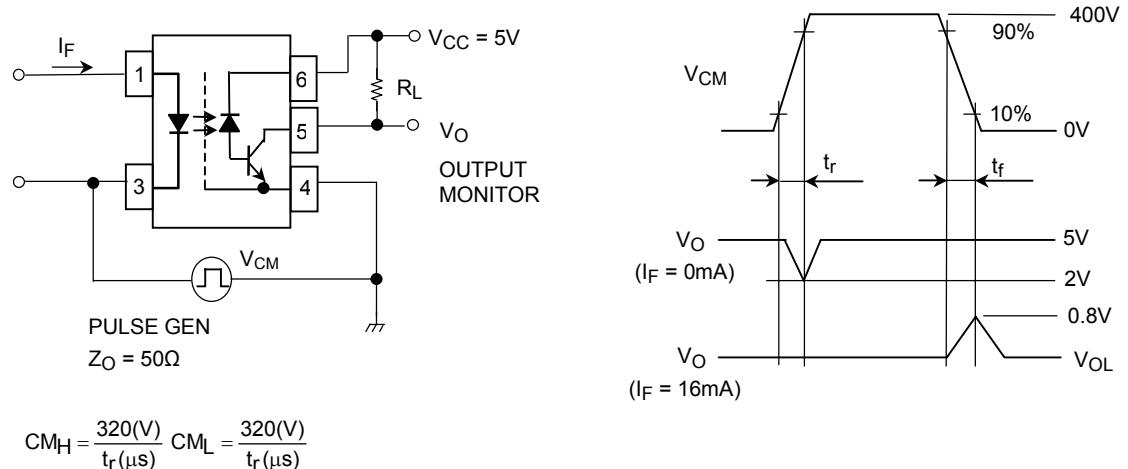
(Note 5) Device considered a two-terminal device: Pins 1 and 3 shorted together, and pins 4, 5 and 6 shorted together.

(Note 6) Maximum electrostatic discharge voltage for any pins: 100V(C=200pF, R=0)

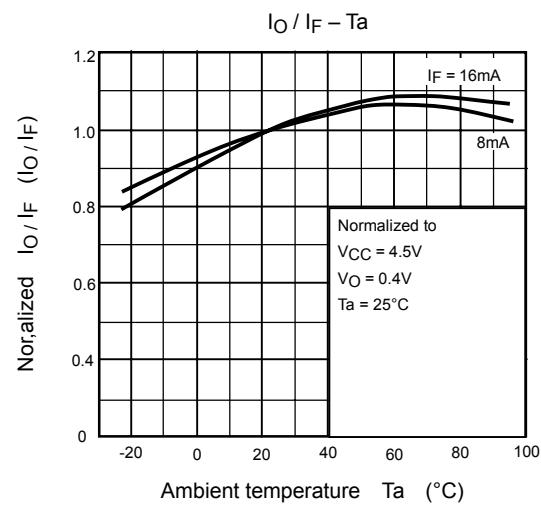
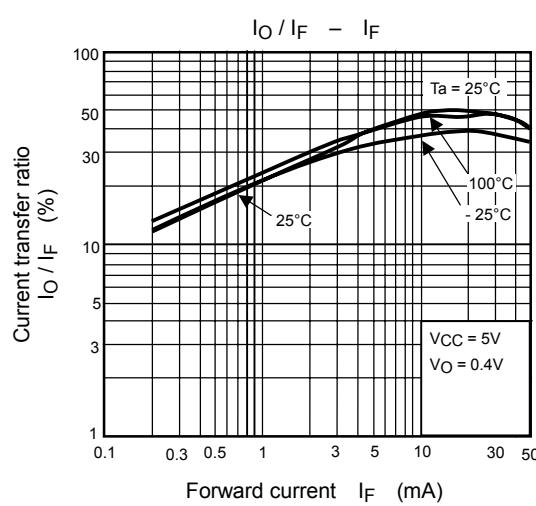
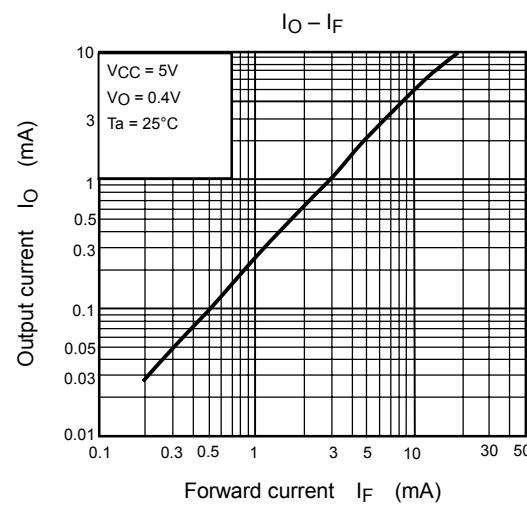
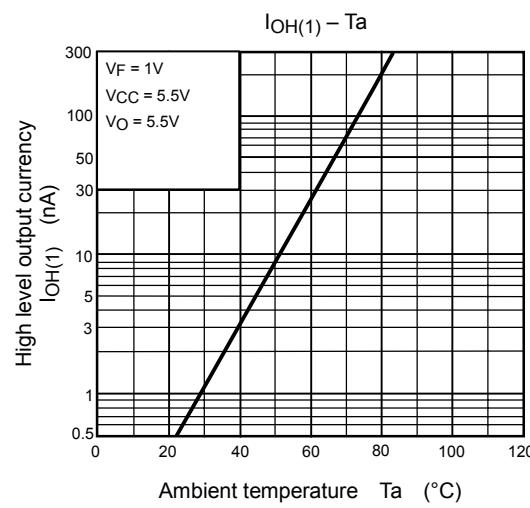
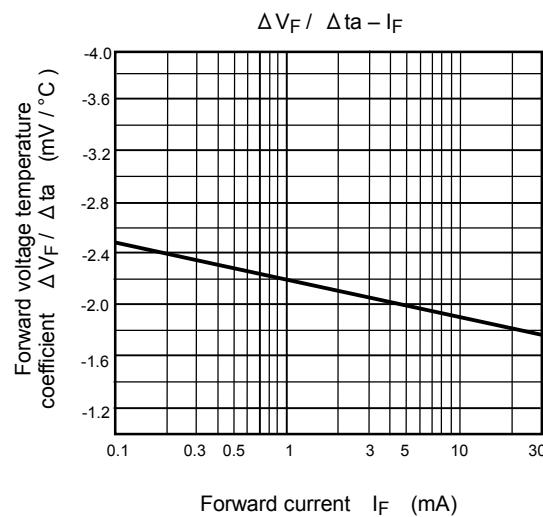
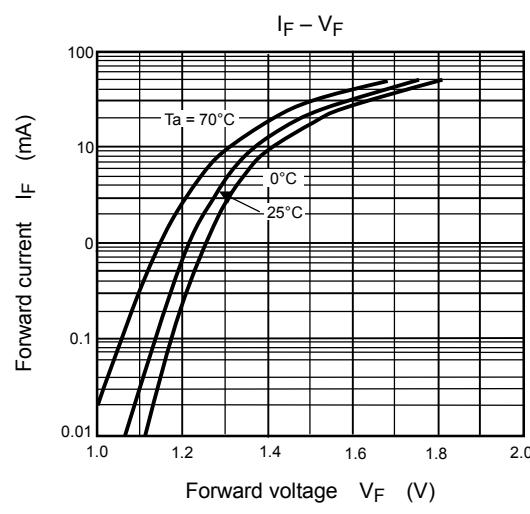
Test Circuit 1: Switching Time Test Circuit

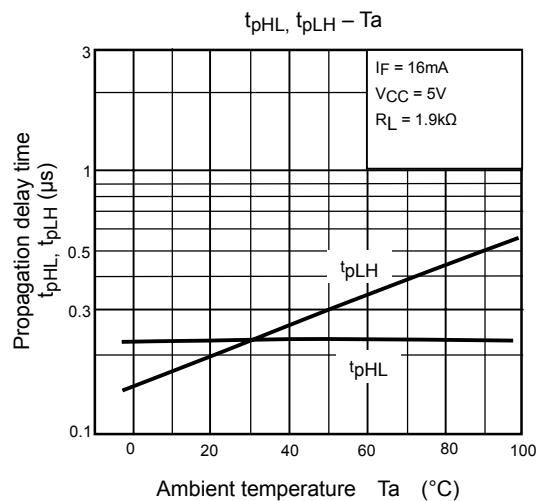
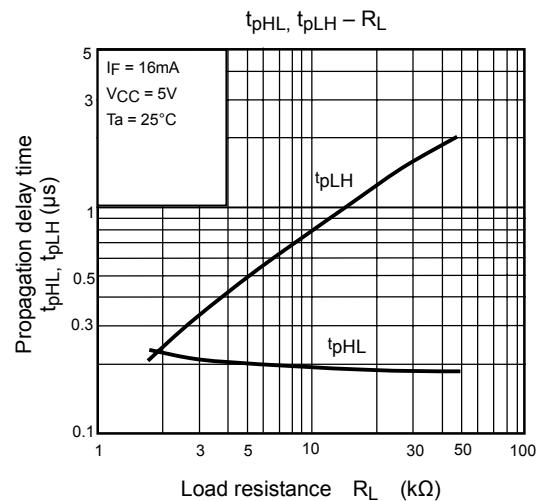
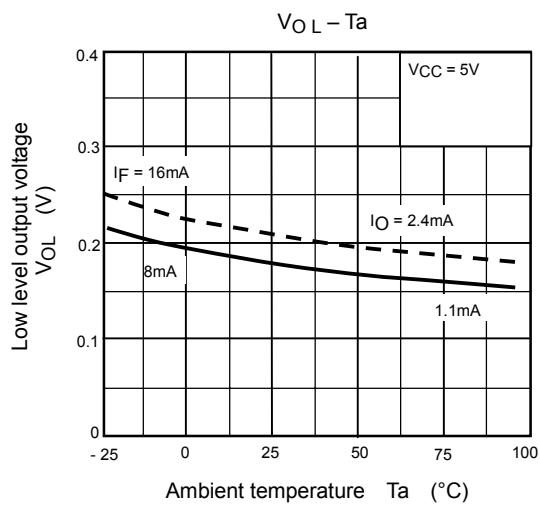
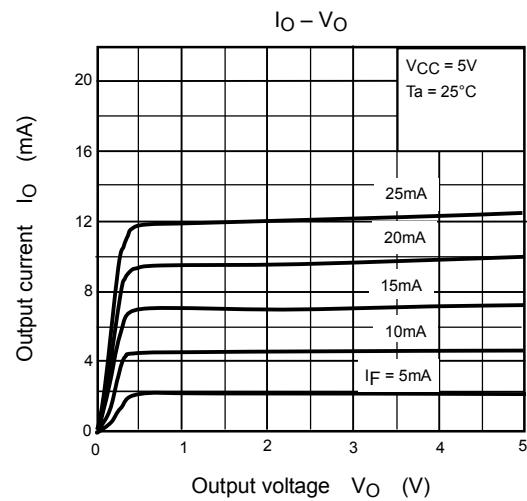


Test Circuit 2: Common Mode Transient Immunity Test Circuit



$$CM_H = \frac{320(V)}{t_r(\mu s)}, CM_L = \frac{320(V)}{t_f(\mu s)}$$





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